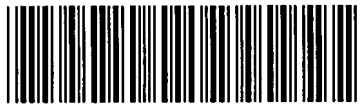


<b>Search Notes</b>  	<b>Application/Control No.</b>  10542147	<b>Applicant(s)/Patent Under Reexamination</b>  YAMADA ET AL.
	<b>Examiner</b>  Liu, Benjamin T	<b>Art Unit</b>  2826

SEARCHED			
Class	Subclass	Date	Examiner
257	53,56,458,e31.034,e31.061,e31.094	10/28/07	BTL

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search see attached printout. Received search help from Primary Examiner Minh Loan Tran.	10/28/07	BTL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	53,56,458	10/28/07	BTL
136	249,258,261	10/28/07	BTL